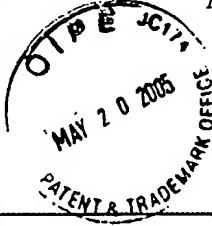


INFORMATION DISCLOSURE CITATION IN AN APPLICATION  (PTO-1449)			ATTY. DOCKET NO. 060188-0664	SERIAL NO. 10/674,068		
			APPLICANT Makoto TSUTSUE, et al.			
			FILING DATE September 30, 2003	GROUP 2814		
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
		US				
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FOREIGN PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number + Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation
LP		JP 2001-223339 A	08/17/2001	LUCENT TECHNOL INC.		Yes No
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				
EXAMINER <i>Long Pham</i>			DATE CONSIDERED <i>6/15/03</i>			

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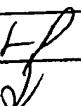
1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

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LP	US	6,656,826 B2	12-2-2003	Ishimaru	Corresponds to JP 2002-110799		
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EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number -Kind Codes(if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes	Translation No
LP		JP 2002-110799	4-12-2002	TOSHIBA CORP	Corresponds to US 6,656,826 B2	w/English Abstract	
		JP 2001-156172	6-8-2001	HITACHI LTD		w/English Abstract	
		JP 2001-326242	11-22-2001	MATSUSHITA ELECTRIC IND CO LTD		w/English Abstract	
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.					
EXAMINER <i>Long Pham</i>				DATE CONSIDERED <i>6/15/05</i>			

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				APPLICANT Makoto TSUTSUE, et al.		
				FILING DATE September 30, 2003	GROUP	
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code(s if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
	US	US 2002/025623 A1	02/28/2002	Yamamichi et al.		
	US	US 2001/0020713 A1	09/13/2001	Yoshitomi et al.		
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EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number + Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation
		JP 2001-237375 (w/ English Abstract)	08/31/2001	TOSHIBA CORP.		Yes
		JP 2002-33453 (w/ English Abstract)	01/31/2002	NEC CORP.		No
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
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EXAMINER <i>Loyd Pharr</i>			DATE CONSIDERED <i>6/15/05</i>			

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